



EMC TEST REPORT

Report No.:	SET2015-09052
Product:	LED Fire Rated Downlight
Model No:	5RS015-1, 5RS015-2, 5RS015-3, 5RS015-4, 5RS015-5
Brand Name:	/
Applicant:	Suzhou Radiant Lighting Technology Co.,Ltd
Issued by:	CCIC Southern Electronic Product Testing (Shenzhen) Co., Ltd.
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Test Report

Product. :	LED Fire Rated Downlight			
Model No:	5RS015-1, 5RS015-2, 5RS015-3, 5RS015-4, 5RS015-5			
Brand Name:	/			
Applicant:	Suzhou Radiant Lighting Technology Co.,Ltd			
Applicant Address:	Jiatai Road West, Shuanglong Industrial Park, Fenghuang Town, Zhangjiagang City, Jiangsu , China.			
Manufacturer:	Suzhou Radiant Lighting Technology Co.,Ltd			
Manufacturer Address:	Jiatai Road West, Shuanglong Industrial Park, Fenghuang Town, Zhangjiagang City, Jiangsu , China.			
Test Standards	 EN55015:2013 Limits and methods of measurement of radio disturbance characteristics of electrical lighting and similar equipment EN 61547:2009 Equipment for general lighting purposes - EMC immunity requirements EN61000-3-2:2014 Electromagnetic compatibility (EMC) Part 3-2: Limits - Limits for harmonic current emissions (equipment input current <= 16 A per phase) EN61000-3-3:2013 Electromagnetic compatibility (EMC) Part 3-3: Limits - Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems 			
Test Result:	Pass			
Tested by:				
Reviewed by:	Jul.07.2015 Signature, Date Www lim Jul.07.2015 Signature, Date			



Table of Contents

Τe	st Report	2
1	General Information	5
	1.1 Description of EUT	5
	1.2 Objective	6
	1.3 Environmental Conditions	6
	1.4 Measurement Uncertainty	6
	1.5 Test Standards and Results	7
	1.6 List of Equipments Used	8
2	Emission Test	9
	2.1 EUT Setup and Operating Conditions	9
	2.2 Mains Terminal Disturbance Voltage Measurement	9
	2.2.1 Limits of Mains Terminal Disturbance Voltage	9
	2.2.2 Test Procedure	9
	2.2.3 Test Setup	10
	2.2.4 Test Result	10
	2.3 Radiated Electromagnetic Disturbance Measurement	12
	2.3.1 Limits of Radiated Electromagnetic Disturbance	12
	2.3.2 Test Procedure	12
	2.3.3 Test Setup	13
	2.3.4 Test Results	13
	2.4 Radiated Disturbance Measurement	15
	2.4.1 Limits of Radiated Disturbance	15
	2.4.2 Test Setup	15
	2.4.3 Test Result	16
	2.5 Harmonic Current Measurement	18
	2.5.1 Limits of Harmonic Current	18
	2.5.2 Test Procedure	18
	2.5.3 Test Setup	19
	2.5.4 Test Result	19
	2.6 Voltage Fluctuation and Flick Measurement	21
	2.6.1 Limits of Voltage Fluctuation and Flick	21
	2.6.2 Test Procedure	
	2.6.3 Test Result	
	3 Immunity Test	22
	3.1 EUT Setup and Operating Conditions	



3.2 Performance Criteria	22
3.3 Electrostatic Discharge Immunity Test	22
3.3.1 Test Specification	22
3.3.2 Test Procedure	23
3.3.3 Test Setup	24
3.3.4 Test Result	25
3.4 Radiated, Radio Frequency Electromagnetic Field Immunity Test	
3.4.1 Test Specification	
3.4.2 Test Procedure	
3.4.3 Test Setup	
3.4.4 Test Result	
3.5 Electrical Fast Transient/Burst Immunity Test	
3.5.1 Test Specification	
3.5.2 Test Procedure	
3.5.3 Test Setup	
3.5.4 Test Result	31
3.6 Surge Immunity Test	
3.6.1 Test Specification	
3.6.2 Test Procedure	
3.6.3 Test Setup	
3.6.4 Test Result	
3.7 Immunity to Conducted Disturbances Induced by RF Fields	
3.7.1 Test Specification	
3.7.2 Test Procedure	
3.7.3 Test Setup	
3.7.4 Test Result	
3.8 Power Frequency Magnetic Field Immunity Test	
3.8.1 Test Specification	
3.8.2 Test Procedure	
3.8.3 Test Setup	
3.8.4 Test Result	
3.9 Voltage Dips and Short Interruptions Immunity Test	
3.9.1 Test Specification	
3.9.2 Test Procedure	
3.9.3 Test Setup	
3.9.4 Test Result	
Appendix I: Photographs of the EUT	

A



1 General Information

1.1 Description of EUT

Product:	LED Fire Rated Downlight
Model No.:	5RS015-5
Brand Name:	/
Electrical Rating:	200-240VAC, 50/60Hz

NOTE:

1. For more detailed features about the EUT, please refer to the manufacture's specification or the user's manual.

For the emission tests ,the details of test mode are as follows:

Pre-test modes are as follows:

Test Mode	Test Sample	Note
Mode 1	5RS015-1	Normal Operation
Mode 2	5RS015-2	Normal Operation
Mode 3	5RS015-3	Normal Operation
Mode 4	5RS015-4	Normal Operation
Mode 5	5RS015-5	Normal Operation

From the above preliminary survey, Mode 5 was the worst case of all emission test modes. It was selected as representative model for the final test and its data were recorded in this report.

Final Test mode and recorded.

Test Item	Test Mode	Note		
ElectroMagnetic Interference Test	e Test Mode 5 Normal Operation			
ElectroMagnetic Susceptibility Test	Mode 5	Normal Operation		



1.2 List of configuration

Model No	Fuse wire	Inductance	Transformer	Function
5RS015-1	1W 10R	3.3mH	EE1621	Non dimmable
5RS015-2	1W 10R	3.3mH	EE1621	Non dimmable
5RS015-3	1W 47R	5.1mH	EE1619	dimmable
5RS015-4	1W 47R	5.1mH	EE1622	dimmable
5RS015-5	1W 47R	5.1mH	EE1622	dimmable

1.3 Environmental Conditions

During the measurement the environmental conditions were within the listed ranges:

- Temperature: 15-25°C
- Humidity: 30-60 %
- Atmospheric pressure: 86-106 kPa

1.4 Measurement Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

- Uncertainty of Mains terminal disturbance voltage, $Uc = \pm 3.6 dB$
- Uncertainty of Radiated disturbance(30MHz 300MHz), Uc = ±4.7dB
- Uncertainty of Radiated Emission(9KHz 30MHz), Uc = \pm 3.4dB



1.5 Test Standards and Results

The EUT has been tested according to the following specifications:

EMISSION					
Standard Test Type					
	Mains terminal disturbance voltage	PASS			
EN55015:2013	RadiatedElectromagneticDisturbanceMeasurement(9kHz-30MHz)	PASS			
	RadiatedElectromagneticDisturbanceMeasurement(30MHz-300MHz)	PASS			
EN61000-3-2: 2014	Harmonic current emissions	PASS			
EN61000-3-3: 2013	Voltage fluctuation & flicker	PASS			
IMMUNITY (EN 61547:2009)					
Basic Standard Test Type					
IEC 61000-4-2	Electrostatic discharge immunity	PASS			
IEC 61000-4-3	Radiated, radio frequency electromagnetic field immunity	PASS			
IEC 61000-4-4	Electrical fast transient/burst immunity	PASS			
IEC 61000-4-5	Surge immunity	PASS			
IEC 61000-4-6	Immunity to conducted disturbances induced by RF fields	PASS			
IEC 61000-4-8	Power frequency magnetic field immunity	PASS			
IEC 61000-4-11	Voltage dips and short interruptions immunity	PASS			

NOTE: The latest versions of basic standards are applied.



1.6 List of Equipments Used

Description	Manufacturer	Model No.	Calibration Due Date	Serial No.
Test Receiver	Schwarzbeck	FCKL1528	Jun. 10. 2016	A0304230
Test Receiver	ROHDE&SCHWARZ	ESCI	Jun. 10. 2016	A0304260
LISN	ROHDE&SCHWARZ	ESH2-Z5	Jun. 10. 2016	A0304221
Loop Antenna	Schwarzbeck	HXYZ8170	Jun. 10. 2016	A0304232
Test Receiver	ROHDE&SCHWARZ	ESIB7	Jun. 10. 2016	A0501375
Broadband Ant.	CHASE	CBL6111A	Jun. 10. 2016	A9704202
Anechoic Chamber	Albatross	EMC 9*6*6 (m)	Mar. 09. 2016	A0412372
Antenna	Amplifier Research	AR AT1080	Jun. 10. 2016	A0304249
ESD Test System	EM TEST	ESD30C	Jul. 03. 2016	A0712513
EFT/Surge Test	EM TEST	UCS500N7.7	Jun. 10. 2016	A130201094
System	EM TEST	CNI503B9.3	Jun. 10. 2016	A130201095
Signal Generator	ROHDE&SCHWARZ	SML01	Jun. 10. 2016	A0502382
Power Amplifier	Amplifier Research	AR 150W1000	150W1000 /	
Power Amplifier	Amplifier Research	AR 75A250A	Jun. 10. 2016	A0304255
Anechoic Chamber	Albatross	H-249	Mar. 07. 2016	A0304210
CDN	ROHDE&SCHWARZ	M3	Feb.20.2016	A0304306
Magnetic Field Tester	HAEFELY	MAG 100.1	Jun. 10. 2016	A0103109
Shield Room	Nanbo Tech	Site 3	Jun. 10. 2016	A9901141
Shield Room	Nanbo Tech	Site 2	Jun. 10. 2016	A0304210
Power Frequency Test System	CI	15003iX-400-CT S	Aug. 10. 2016	A0801521
Van der Hoofden Test-Head Protection Network	AFJ	VDH30	Jun. 10. 2016	A130301233

NOTE: Equipments listed above have been calibrated and are in the period of validation.



2 Emission Test

2.1 EUT Setup and Operating Conditions

The EUT was powered by 230V 50Hz AC Mains and operated at rating condition.

2.2 Mains Terminal Disturbance Voltage Measurement

2.2.1 Limits of Mains Terminal Disturbance Voltage

F	Limits (dBµV)			
Frequency range	Quasi-peak	Average		
9kHz to 50kHz	110			
50kHz to 150kHz	90 to 80			
150kHz to 0.5MHz	66 to 56	56 to 46		
0.5MHz to 5.0MHz	56	46		
5.0MHz to 30MHz	60	50		

NOTE:

- 1. The lower limit shall apply at the transition frequencies.
- 2. The limit decreases linearly with the logarithm of the frequency in the range 50 kHz to 150 kHz and 150 kHz to 0.5MHz.

2.2.2 Test Procedure

- a. The EUT was placed 0.8 meters from the conducting wall of shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN). The LISN provide $50\Omega/50\mu$ H of coupling impedance for the measuring instrument.
- b. Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- c. The frequency range from 9 kHz to 30MHz was searched. Emission levels over 10dB under the prescribed limits are not reported.



2.2.3 Test Setup

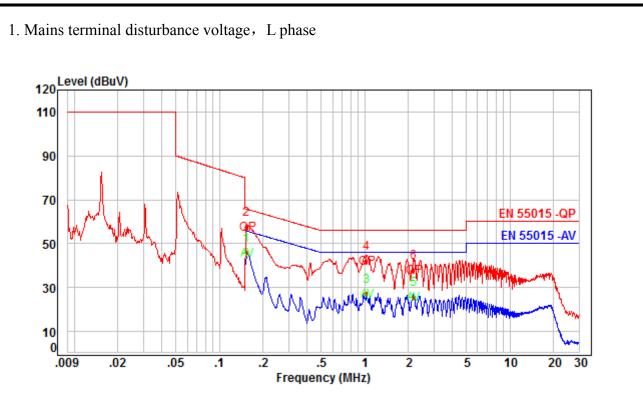
For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

	Frequency	Factor	Reading	Level	Limit	Margin	Detector
Line	(MHz)	(dB)	(dBuV)	(dBuV)	(dBuV)	(dB)	Delector
L	0.1540	9.66	36.41	46.07	55.7	9.71	Average
L	0.1540	9.66	47.91	57.57	65.7	8.21	QP
L	1.0270	9.74	17.6	27.34	46	18.66	Average
L	1.0270	9.74	32.3	42.04	56	13.96	QP
L	2.1550	9.78	15.9	25.68	46	20.32	Average
L	2.1550	9.78	28.1	37.88	56	18.12	QP
N	0.1560	9.58	36.1	45.68	55.6	9.99	Average
N	0.1560	9.58	47.2	56.78	65.6	8.89	QP
N	1.0210	9.74	17.7	27.44	46	18.56	Average
N	1.0210	9.74	32.2	41.94	56	14.06	QP
N	2.1900	9.76	16.51	26.27	46	19.73	Average
N	2.1900	9.76	30.01	39.77	56	16.23	QP

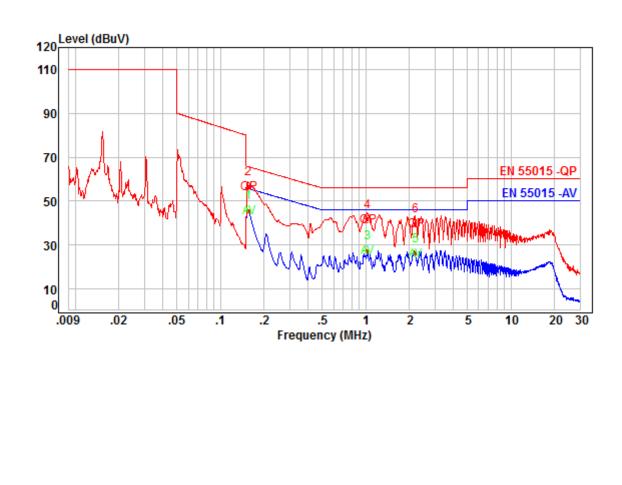
2.2.4 Test Result

- 1. QP and AV are abbreviations of the quasi-peak and average individually.
- 2. If the emission levels measured with QP detector are lower than AV limits, there is unnecessary to measure with AV detector.





2. Mains terminal disturbance voltage, N phase





2.3 Radiated Electromagnetic Disturbance Measurement

2.3.1 Limits of Radiated Electromagnetic Disturbance

Frequency range (MHz)	QP Limits(dBµV), for loop antenna with a diameter of 2m
0.009 to 0.07	88
0.07 to 0.15	88 to 58
0.15 to 3.0	58 to 22
3.0 to 30	22

Notes:

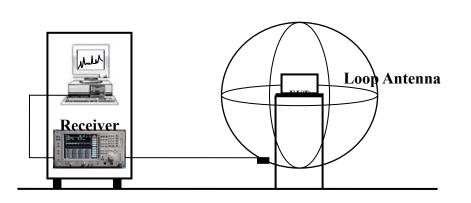
- (1) The lower limit shall apply at the transition frequency.
- (2) The limit decreases linearly with the logarithm of the frequency in the range 70 kHz to 150 kHz and 0.15MHz to 3MHz.

2.3.2 Test Procedure

- a. The magnetic component of radiated electromagnetic disturbance is measured by means of a loop antenna.
- b. The induced current in the loop antenna is measured by means of a current probe (1V/A) and the CISPR measuring receiver. By means of a coaxial switch, the three field directions are measured in sequence.
- c. The EUT was placed in the center of the loop antenna, on an insulated table.



2.3.3 Test Setup



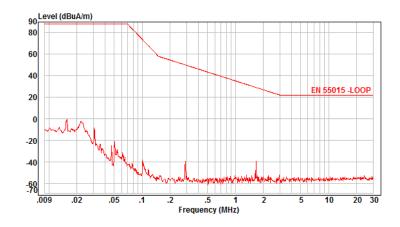
For the actual test configuration, please refer to the related item-Photographs of the Test Configuration.

2.3.4 Test Results

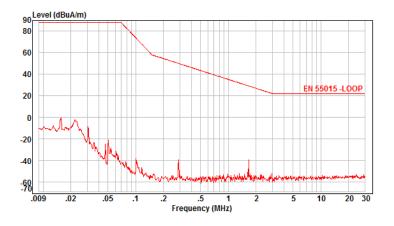
No.	Antenna Direction	Frequency (MHz)	QP Limits (dB A)	Emission Level (dB)
1	X/Y/Z	0.009 to 0.07	88	<10
2	X/Y/Z	0.07 to 0.15	50.09	<10
3	X/Y/Z	0.15 to 3.0	88	<10
4	X/Y/Z	3.0 to 30	88	<10



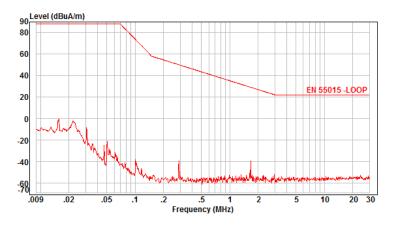
1. Radiated electromagnetic disturbance, loop antenna direction: X



2. Radiated electromagnetic disturbance, loop antenna direction: Y



3. Radiated electromagnetic disturbance, loop antenna direction: Z





2.4 Radiated Disturbance Measurement

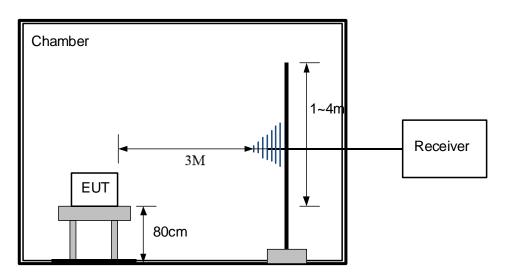
2.4.1 Limits of Radiated Disturbance

Frequency range (MHz)	Quasi peak limits(dBµV/m), for Class B ITE, at 3m measurement distance
30 to 230	40
230 to 1000	47

Notes:

(1) The lower limit shall apply at the transition frequency.

2.4.2 Test Setup

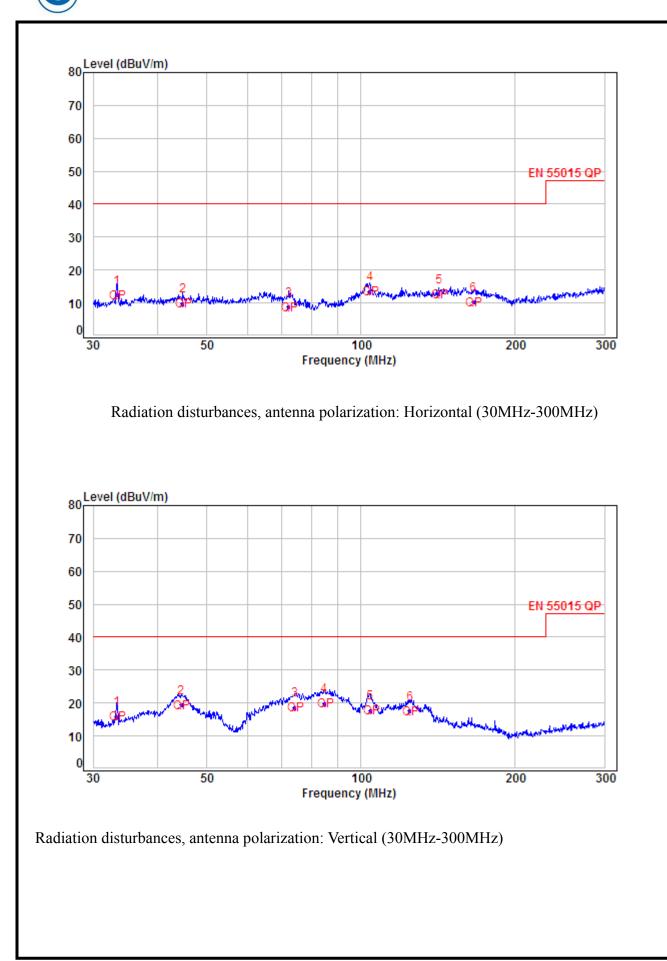






2.4.3 Test Result

	Frequency	Factor	Reading	Level	Limit	Margin		Height	Azimuth
No.	(MHz)	(dB/m)	(dBuV)	(dBuV/m)	(dBuV/m)	(dB)	Detector	(cm)	(。)
Н	33.352	-13.83	26.2	12.37	40	27.63	QP	200	123
н	44.784	-13.15	22.9	9.75	40	30.25	QP	200	100
Н	72.297	-15.09	23.9	8.81	40	31.19	QP	100	112
Н	104.261	-14.2	27.61	13.41	40	26.59	QP	300	360
Н	142.273	-10.9	23.6	12.7	40	27.3	QP	200	12
Н	166.005	-10.57	20.89	10.32	40	29.68	QP	200	34
V	33.275	-13.83	29.79	15.96	40	24.04	QP	100	227
V	44.476	-13.15	32.6	19.45	40	20.55	QP	100	40
V	74.323	-15.53	34.2	18.67	40	21.33	QP	100	300
V	84.942	-16.63	36.4	19.77	40	20.23	QP	100	280
V	104.501	-14.17	31.9	17.73	40	22.27	QP	100	70
V	124.773	-12.24	29.81	17.57	40	22.43	QP	100	190





2.5 Harmonic Current Measurement

Limits for	Limits for Class C Equipment			
Harmonics Order n Max. permissible harmonic current				
	expressed as percentage of the input current at the fundamental frequency(A)			
2	2			
3	$30 \times \lambda^*$			
5	10			
7	7			
9	5			
11≤n≤39	3			
(odd harmonics only)				

2.5.1 Limits of Harmonic Current

NOTE:

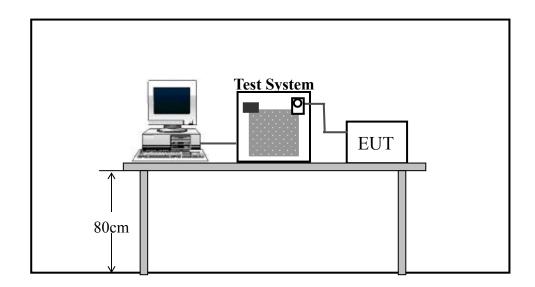
1. According to section 5 of EN61000-3-2: 2006, the EUT is Class C equipment.

2.5.2 Test Procedure

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- b. The correspondent test program of test instrument to measure the current harmonics emanated from EUT is chosen. The measure time shall be not less than the necessary for the EUT to be exercised.



2.5.3 Test Setup



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

2.5.4 Test Result

Test category: Class-C per Ed. 3.2 (2009) (European limits) Test Margin: 100						
Test date: 2015/6/19 Test duration (min): 2		rt time: 14:5 a file name:	8:48 H-000129.cts_d	End time: 15 ata	:01:40	
Comment: Comme	nts					
Customer: Custom	er					
Test Result: Pass THC(A): 0.008	I-THD(%): 21.		n: Normal POHC(A): 0.00	0 PC	OHC Limit(A)	: 0.004
Highest parameter v	0	t:				
V_RMS (Vol	s): 230.28		Frequency(Hz):	50.00		
I_Peak (Amp	s): 0.090		I_RMS (Amps):	0.039		
I_Fund (Amp	s): 0.038		Crest Factor:	2.380		
Power (Watt	s): 8.3		Power Factor:	0.927		
Harm# Harms(avg	100%Limit	%of Limit	Harms(max)	150%Limit	%of Limit	Status
2 0.00	0.001	N/A	0.000	0.001	N/A	Pass
3 0.000	0.011	48.4	0.007	0.017	38.5	Pass
4 0.000)					
5 0.003	0.004	N/A	0.000	0.006	N/A	Pass



								-
6	0.000							
7	0.003	0.003	N/A	0.000	0.004	N/A	Pass	
8	0.000							
9	0.002	0.002	N/A	0.000	0.003	N/A	Pass	
10	0.000							
11	0.002	0.001	N/A	0.000	0.002	N/A	Pass	
12	0.000							
13	0.001	0.001	N/A	0.000	0.002	N/A	Pass	
14	0.000							
15	0.001	0.001	N/A	0.000	0.002	N/A	Pass	
16	0.000							
17	0.001	0.001	N/A	0.000	0.002	N/A	Pass	
18	0.000							
19	0.001	0.001	N/A	0.000	0.002	N/A	Pass	
20	0.000							
21	0.001	0.001	N/A	0.000	0.002	N/A	Pass	
22	0.000							
23	0.001	0.001	N/A	0.000	0.002	N/A	Pass	
24	0.000						_	
25	0.000	0.001	N/A	0.000	0.002	N/A	Pass	
26	0.000	0.004	N1/A			N 1/A	5	
27	0.000	0.001	N/A	0.000	0.002	N/A	Pass	
28	0.000	0.004	N1/A	0.000	0.000	N1/A	Deee	
29	0.000	0.001	N/A	0.000	0.002	N/A	Pass	
30	0.000	0.001	N1/A	0.000	0.000	N1/A	Deee	
31	0.000	0.001	N/A	0.000	0.002	N/A	Pass	
32	0.000	0.001	N/A	0.000	0.000	N/A	Daga	
33 34	0.000 0.000	0.001	IN/A	0.000	0.002	IN/A	Pass	
34 35	0.000	0.001	N/A	0.000	0.002	N/A	Pass	
36	0.000	0.001		0.000	0.002	IN/A	F 855	
37	0.000	0.001	N/A	0.000	0.002	N/A	Pass	
38	0.000	0.001		0.000	0.002	IN/ <i>I</i> A	1 435	
39	0.000	0.001	N/A	0.000	0.002	N/A	Pass	
40	0.000	0.001		0.000	0.002			
.0	0.000							

Note: Dynamic limits were applied for this test. The highest harmonics values in the above table may not occur at the same window as the maximum harmonics/limit ratio.



2.6 Voltage Fluctuation and Flick Measurement

Test Item	Limit	Note
P _{st}	1.0	P _{st} means Short-term flicker indicator
P _{lt}	0.65	P _{lt} means long-term flicker indicator
T _{dt}	500mS	T_{dt} means maximum time that d_t exceeds 3%
$d_{max}(\%)$	4%	d _{max} means maximum relative voltage change.
D _c (%)	3.3%	d _c means relative steady-state voltage change.

2.6.1 Limits of Voltage Fluctuation and Flick

2.6.2 Test Procedure

- a. The EUT was placed on the top of a wooden table 0.8 meters above the ground and operated to produce the most unfavorable sequence of voltage changes under normal conditions
- b. During the flick measurement, the measure time shall include that part of whole operation changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

2.6.3 Test Result

Test Specification

Test Frequency:	50Hz	Test Voltage:	230VAC 50Hz
Waveform:	Sine	Test Time:	10 minutes(P _{st}); 2 hours (P _{lt})

Test Result

Test Parameter	Measurement Value	Limit	Remarks
P _{st}	0.064	1.0	Pass
P _{lt}	0.028	0.65	Pass
T _{dt(s)}	0.00	500mS	Pass
$d_{max}(\%)$	0.00%	4%	Pass
$d_c(\%)$	0.00%	3.3%	Pass



3 Immunity Test

3.1 EUT Setup and Operating Conditions

Same as 2.1

3.2 Performance Criteria

Criterion A	During the test no change of the luminous intensity shall be observed and the regulating
	control, if any, shall operate during the test as intended.
	During the test the luminous intensity may change to any value. After the test the luminous
	intensity shall be restored to its initial value within 1 minute.
Criterion B	Regulating controls need not function during the test, but after the test the mode of the control
	shall be the same as before the test provided that during the test no mode changing commands
	were given.
	During and after the test any change of the luminous intensity is allowed and the lamp(s) may
	be extinguished. After the test, within 30 minutes, all functions shall return to normal if
	necessary be by temporary interruption of the mains supply and/or operating the regulating
Criterion C	control.
	Additional requirement for lighting equipment incorporating a starting device:
	After the test the lighting equipment is switch off. After half an hour it is switched on again.
	The lighting equipment shall start and operate as intended.

3.3 Electrostatic Discharge Immunity Test

3.3.1 Test Specification

Basic Standard:	IEC 61000-4-2
Discharge Impedance	330Ω / 150 pF
Discharge Voltage:	Air Discharge: 8 kV
	Contact Discharge: 4 kV
Polarity:	Positive / Negative
Number of Discharge:	Minimum 20 times at each test point
Discharge Mode:	Single discharge
Discharge Period:	1-second minimum
Criterion:	В



3.3.2 Test Procedure

The discharges shall be applied in two ways:

a. Contact discharges to the conductive surfaces and coupling planes:

The EUT shall be exposed to at least 200 discharges, 100 each at negative and positive polarity, at a minimum of four test points. One of the test points shall be subjected to at least 50 indirect discharges to the center of the front edge of the horizontal coupling plane. The remaining three contact test points shall each receive at least 50 direct contact discharges. If no direct contact test points are available, at least 200 indirect discharges shall be applied in the indirect mode. Test shall be performed at a maximum repetition rate of one discharge per second.

b. Air discharges at slots and apertures and insulating surfaces:

On those parts of the EUT where it is not possible to perform contact discharge testing, the equipment should be investigated to identify user accessible points where breakdown may occur. Such points are tested using the air discharge method. This investigation should be restricted to those area normally handled selected test point for each such area.

The basic test procedure was in accordance with IEC 61000-4-2:

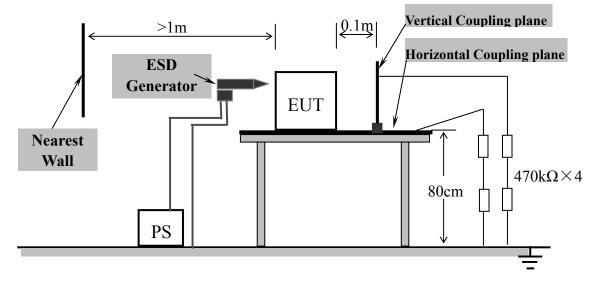
- a. Electrostatic discharges were applied only to those points and surfaces of the EUT that are accessible to users during normal operation.
- b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- c. The time interval between two successive single discharges was at least 1 second.
- d. The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the EUT.
- e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the EUT as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator was removed from the EUT and re-triggered for a new single discharge. The test was repeated until all discharges were completed.
- g. At least ten single discharges (in the most sensitive polarity) were applied to the Horizontal Coupling Plane at points on each side of the EUT. The ESD generator was positioned



vertically at a distance of 0.1 meters from the EUT with the discharge electrode touching the HCP.

h. At least ten single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the Vertical Coupling Plane in sufficiently different positions that the four faces of the EUT were completely illuminated. The VCP (dimensions 0.5m×0.5m) was placed vertically to and 0.1 meters from the EUT.

3.3.3 Test Setup



For the actual test configuration, please refer to Appendix II: Photographs of the Test Configuration.



3.3.4 Test Result

EUT]	LED Fire Rated Downlight				Model		5RS015-5	5RS015-5			
Test Site		4	shield room 3					Test Mode		Mode 1	Mode 1		
CPU						Software /							
Start of Te	f Test 2015.06.19			Environmental Conditions		25℃, 57% I	25℃, 57% RH						
Uncertaint	ncertainties $\pm 0.2\%$				Tested by Odin								
		-	Air I	Disch	arge	(10]	Disch	arge	s @ :	Per 🛛	Fest Point)		
Test	st Test Level (kV) & Test Result criterion									Performance	Docult	Observation	
Location	+2	-2	+4	-4	+8	-8 +12 -12 +15 -15					criterion	Result	
1	Α	А	Α	А	Α	А	N/A	N/A	N/A	N/A	В	Pass	Note1

Contact Discharge (25 Discharges @ Per Test Point)

Test		Te	st Lev	el (kV)	& Test I		Performance Result Observation				
Location	+2	-2	+4	-4	+6	-6	+8	-8	criterion	Result	Observation
2	А	А	А	А	N/A	N/A	N/A	N/A	В	Pass	Note1
3	А	А	А	А	N/A	N/A	N/A	N/A	В	Pass	Note1
4	А	А	А	А	N/A	N/A	N/A	N/A	В	Pass	Note1
5	А	А	А	А	N/A	N/A	N/A	N/A	В	Pass	Note1
6	А	А	А	А	N/A	N/A	N/A	N/A	В	Pass	Note1
7	А	А	А	А	N/A	N/A	N/A	N/A	В	Pass	Note1
8	А	А	А	А	N/A	N/A	N/A	N/A	В	Pass	Note1
9	А	А	А	А	N/A	N/A	N/A	N/A	В	Pass	Note1
10	А	А	А	А	N/A	N/A	N/A	N/A	В	Pass	Note1
11	А	А	А	А	N/A	N/A	N/A	N/A	В	Pass	Note1
12	А	А	А	А	N/A	N/A	N/A	N/A	В	Pass	Note1



	Horizontal Coupling (25 Discharges @ Per Test Point)										
Test	Test Level (kV) & Test Result criterion Performance Result Observat										
Location	+2	-2	+4	-4	+6	-6	+8	-8	criterion	Result	Observation
Front	А	А	А	А	N/A	N/A	N/A	N/A	В	Pass	Note1
Rear	А	А	А	А	N/A	N/A	N/A	N/A	В	Pass	Note1
Left	А	А	А	А	N/A	N/A	N/A	N/A	В	Pass	Note1
Right	А	А	А	А	N/A	N/A	N/A	N/A	В	Pass	Note1

Vertical Coupling (25 Discharges @ Per Test Point)

Test		Test L	Level (kV) &	Performance Result Observation						
Location	+2	-2	+4	-4	+6	-6	+8	-8	criterion	Kesuit	Observation
Front	А	А	А	А	N/A	N/A	N/A	N/A	В	Pass	Note1
Rear	А	А	А	А	N/A	N/A	N/A	N/A	В	Pass	Note1
Left	А	А	А	А	N/A	N/A	N/A	N/A	В	Pass	Note1
Right	А	А	А	А	N/A	N/A	N/A	N/A	В	Pass	Note1

NOTE:

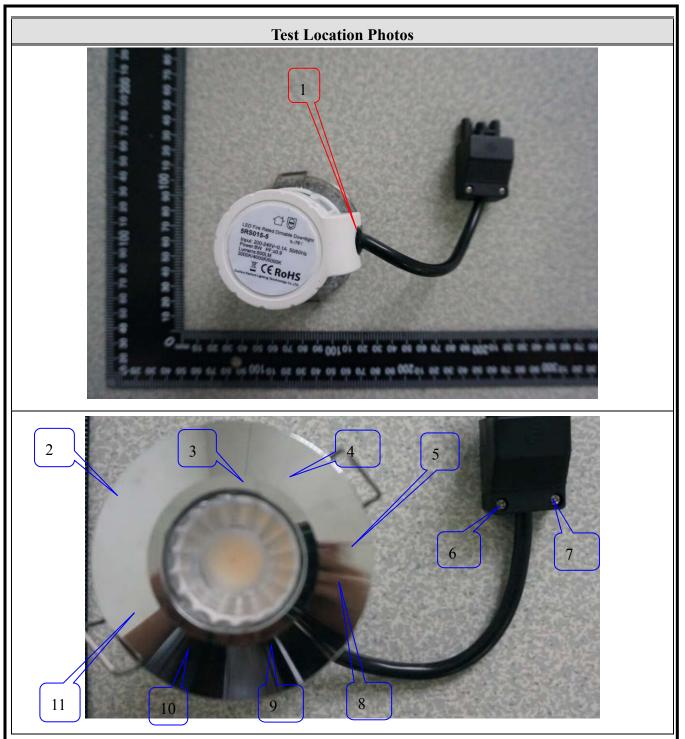
2.

1. The EUT continued to operate as intended. No degradation of performance was observed.

For Air Discharge

3. For Contact Discharge





NOTE:

- (1). The EUT continued to operate as intended. No degradation of performance was observed.
- (2). The luminous intensity decreased and flickered during the test. After the test the luminous intensity self restored within 1 minute, no other degradation of performance or loss of function was observed.



3.4 Radiated, Radio Frequency Electromagnetic Field Immunity Test

3.4.1 Test Specification

Basic Standard:	IEC 61000-4-3
Frequency Range:	80 MHz – 1000MHz
Field Strength:	3V/m
Modulation:	1kHz sine wave, 80%, AM modulation
Frequency Step:	1% of fundamental
Polarity of Antenna	Horizontal and Vertical
Test Distance:	3m
Antenna Height:	1.5m
Dwell Time:	3 seconds
Criterion:	Α

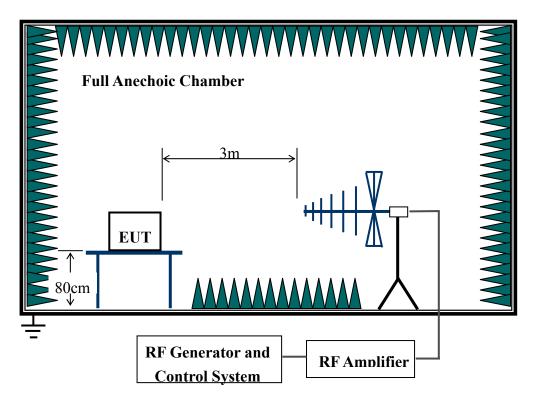
3.4.2 Test Procedure

The test procedure was in accordance with IEC 61000-4-3.

- a. The testing was performed in a fully anechoic chamber. The transmit antenna was located at a distance of 3 meters from the EUT.
- b. The frequency range is swept from 80 MHz to 1000MHz with the signal 80% amplitude modulated with a 1 kHz sine wave. The rate of sweep did not exceed 1.5×10^{-3} decade/s. Where the frequency range is swept incrementally, the step size was 1% of fundamental.
- c. The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- d. The field strength level was 3V/m.
- e. The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.



3.4.3 Test Setup



3.4.4 Test Result

Frequency	Polarity	Azimuth	Field Strength (V/m)	Observation	Performance Criterion
80-1000 MHz	V&H	0	3	Note(1)	А
80-1000 MHz	V&H	90	3	Note(1)	А
80-1000 MHz	V&H	180	3	Note(1)	А
80-1000 MHz	V&H	270	3	Note(1)	А

NOTE:

- (1). The EUT continued to operate as intended. No degradation of performance was observed.
- (2). The luminous intensity decreased and flickered during the test. After the test the luminous intensity self restored within 1 minute, no other degradation of performance or loss of function was observed.



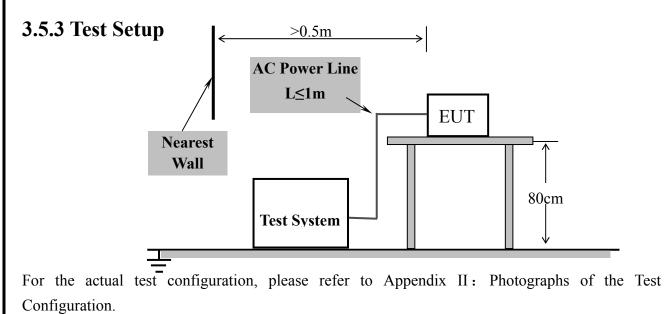
3.5 Electrical Fast Transient/Burst Immunity Test

3.5.1 Test Specification

Basic Standard:	IEC 61000-4-4
Test Voltage:	a.c. power ports: 1 kV
Polarity:	Positive/Negative
Impulse Frequency:	5kHz
Impulse wave shape:	5/50ns
Burst Duration:	15ms
Burst Period:	300ms
Test Duration:	Not less than 2 min.
Criterion:	В

3.5.2 Test Procedure

- a. The EUT was tested with 1000 volt discharges to the AC power input leads.
- b. Both positive and negative polarity discharges were applied.
- c. The length of the "hot wire" from the coaxial output of the EFT generator to the terminals on the EUT should not exceed 1 meter.
- d. The duration time of each test sequential was 1 minute.
- e. The transient/burst waveform was in accordance with IEC 61000-4-4, 5/50ns.





3.5.4 Test Result

Test Point	Polarity	Test Level (kV)	Observation	Performance Criterion
a.c. power port	+/-	0.5	Note (1)	В

NOTE:

- (1). The EUT continued to operate as intended. No degradation of performance was observed.
- (2). The luminous intensity decreased and flickered during the test. After the test the luminous intensity self restored within 1 minute, no other degradation of performance or loss of function was observed.



3.6 Surge Immunity Test

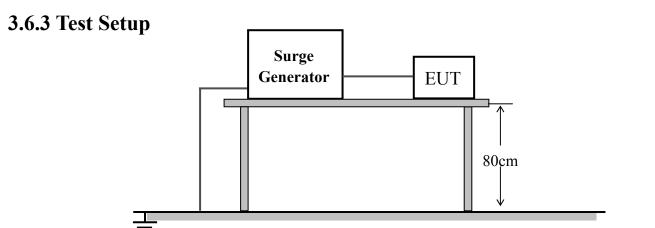
3.6.1 Test Specification

Basic Standard:	IEC 61000-4-5
Waveform:	Voltage 1.2/50 µs
Test Voltage:	Power port, line to line 0.5 kV
Polarity:	Positive/Negative
Repetition Rate:	60sec
Times:	5 times/each condition.
Criterion:	С

3.6.2 Test Procedure

- a. The EUT and the auxiliary equipment were placed on a table of 0.8m heights above a metal ground reference plane. The size of ground plane is greater than 1m×1m and project beyond the EUT by at least 0.1m on all sides. The ground plane is connected to the protective earth. The length of power cord between the coupling device and the EUT was less than 2 meters (provided by the manufacturer).
- b. The EUT was connected to the power mains through a coupling device that directly couples the surge interference signal. The surge noise was applied synchronized to the voltage phase at the zero crossing and the peak value of the AC voltage wave (positive and negative).
- c. The surges were applied line to line and line(s) to earth. When testing line to earth the test voltage was applied successively between each of the lines and earth. Steps up to the test level specified increased the test voltage. All lower levels including the selected test level were tested. The polarity of each surge level included positive and negative test pulses.





For the actual test configuration, please refer to Appendix II: Photographs of the Test Configuration.

3.6.4 Test Result

Coupling Line	Polarity	Voltage (kV)	Observation	Performance Criterion
a.c. power, line to line	+/-	0.5	Note (2)	В

NOTE:

- (1). The EUT continued to operate as intended. No degradation of performance was observed.
- (2). The luminous intensity decreased and flickered during the test. After the test the luminous intensity self restored within 1 minute, no other degradation of performance or loss of function was observed.



3.7 Immunity to Conducted Disturbances Induced by RF Fields

Basic Standard:	IEC 61000-4-6
Frequency Range:	0.15 MHz – 80 MHz
Field Strength:	3V
Modulation:	1 kHz Sine Wave, 80%, AM Modulation
Frequency Step:	1% of fundamental
Coupled Cable:	a.c. power ports
Criterion:	Α

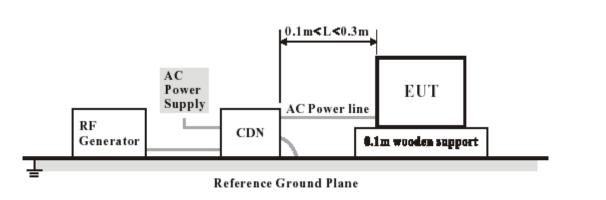
3.7.1 Test Specification

3.7.2 Test Procedure

- a. The EUT shall be tested within its intended operating and climatic conditions.
- b. The test shall be performed with the test generator connected to each of the coupling and decoupling devices in turn, while the other non-excited RF input ports of the coupling devices are terminated by a 50-ohm load resistor.
- c. The frequency range is swept from 150 kHz to 80 MHz, using the signal level established during the setting process and with a disturbance signal of 80% amplitude. The signal is modulated with a 1 kHz sine wave, pausing to adjust the RF signal level or the switch coupling devices as necessary. The sweep rate shall not exceed 1.5×10^{-3} decades/s. The step size shall not exceed 1% of the start and thereafter 1% of the preceding frequency value where the frequency is swept incrementally.
- d. The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised, and able to respond. Sensitive frequencies such as clock frequencies and harmonics or frequencies of dominant interest, shall be analyzed separately.
- e. Attempts should be made to fully exercise the EUT during test, and to fully interrogate all exercise modes selected for susceptibility.



3.7.3 Test Setup



For the actual test configuration, please refer to Appendix II: Photographs of the Test Configuration.

3.7.4 Test Result

Test Point	Frequency	Field Strength (Vrms)	Observation	Performance criterion
a.c. power port	0.15 – 80 MHz	3	Note(1)	А

NOTE:

- (1). The EUT continued to operate as intended. No degradation of performance was observed.
- (2). The luminous intensity decreased and flickered during the test. After the test the luminous intensity self restored within 1 minute, no other degradation of performance or loss of function was observed.



3.8 Power Frequency Magnetic Field Immunity Test

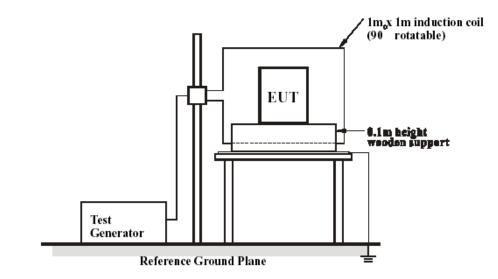
3.8.1 Test Specification

Basic Standard:	IEC 61000-4-8
Frequency Range:	50Hz
Field Strength:	3A/m
Observation Time:	2 minute
Inductance Coil:	Rectangular type, 1m×1m
Criterion:	A

3.8.2 Test Procedure

- a. The equipment is configured and connected to satisfy its functional requirements. It shall be placed on the GRP with the interposition of a 0.1m thick insulating support.
- b. The equipment cabinets shall be connected to the safety earth directly on the GRP via the earth terminal of the EUT.
- c. The power supply, input and output circuits shall be connected to the sources of power supply, control and signal.
- d. The cables supplied or recommended by the equipment manufacturer shall be used. 1 meter of all cables used shall be exposed to the magnetic field.

3.8.3 Test Setup



For the actual test configuration, please refer to Appendix II: Photographs of the Test Configuration.



3.8.4 Test Result

Direction	Field Strength(A/m)	Observation	Comply with Criterion
Х	3	Note(1)	А
Y	3	Note(1)	А
Z	3	Note(1)	А

NOTE:

- (1). The EUT continued to operate as intended. No degradation of performance was observed.
- (2). The luminous intensity decreased and flickered during the test. After the test the luminous intensity self restored within 1 minute, no other degradation of performance or loss of function was observed.





3.9 Voltage Dips and Short Interruptions Immunity Test

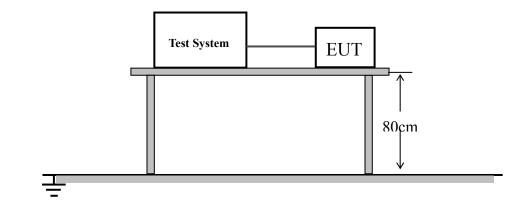
3.9.1 Test Specification

Basic Standard:	IEC 61000-4-11		
Voltage Dips:	30% reduction, 10 periods Criterion: B		
Voltage interruptions 100% reduction, 0.5 periods Criterion: B			

3.9.2 Test Procedure

- a. The power cord was used as supplied by the manufacturer. The EUT was connected to the line output of the Voltage Dips and Interruption Generator.
- b. The EUT was tested for (I) 30% voltage dip of supplied voltage with duration of 200ms, (II) 100% voltage dip of supplied voltage and duration 10ms. Both of the dip tests were carried out for a sequence of three voltage dips with intervals of 10 seconds.
- c. Voltage reductions occur at 0 degree crossover point of the voltage waveform. The performance of the EUT was checked after the voltage dip or interruption.

3.9.3 Test Setup



3.9.4 Test Result

Test Mode	Voltage Reduction	Duration (Period)	Observation	Comply with Criterion
Voltage dips	30%	10	Note (2)	В
Voltage interruptions	100%	0.5	Note (2)	В

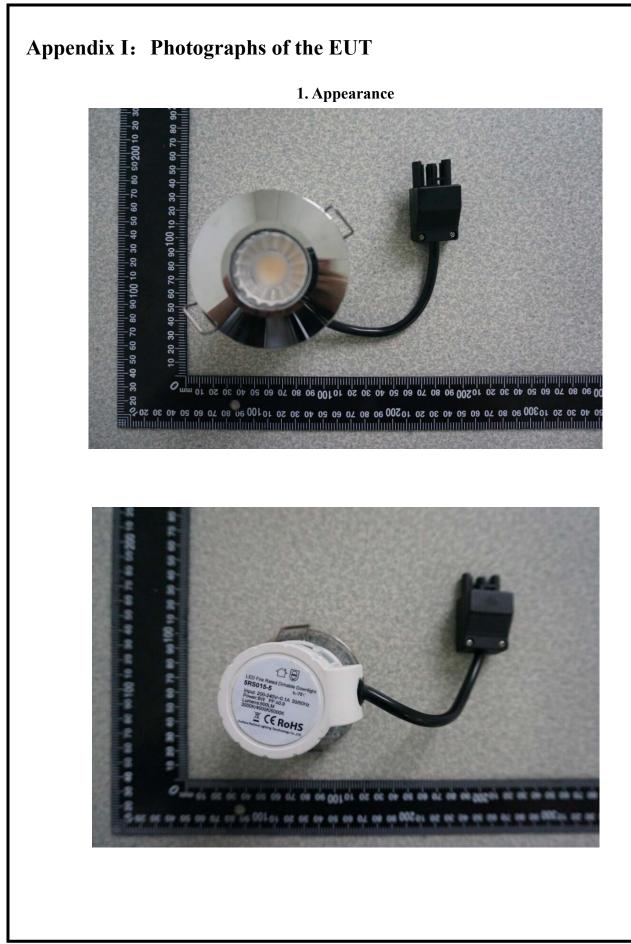
Note:

(1). The EUT continued to operate as intended. No degradation of performance was observed.

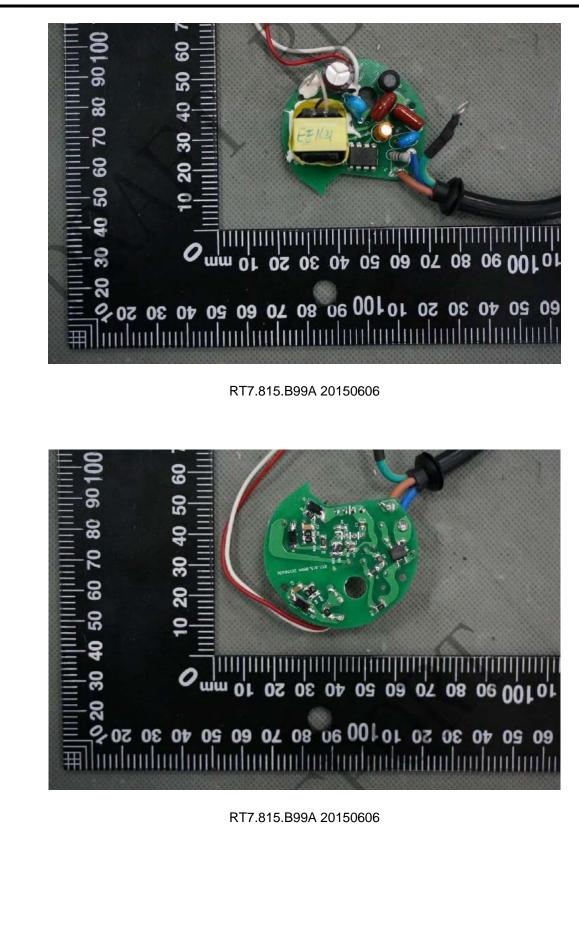
(2). The luminous intensity decreased and flickered during the test. After the test the luminous intensity self restored within 1 minute, no other degradation of performance or loss of function was observed.



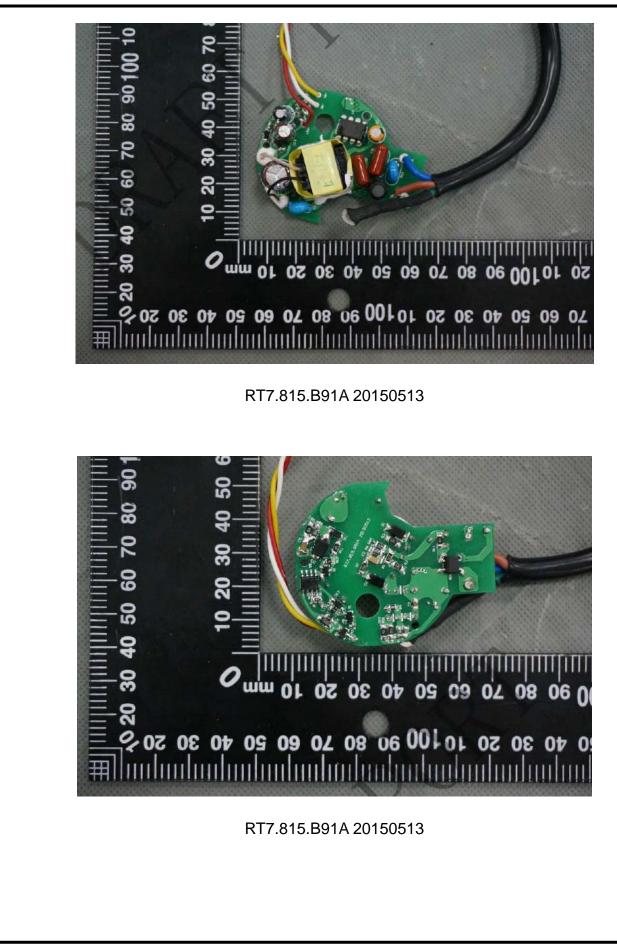






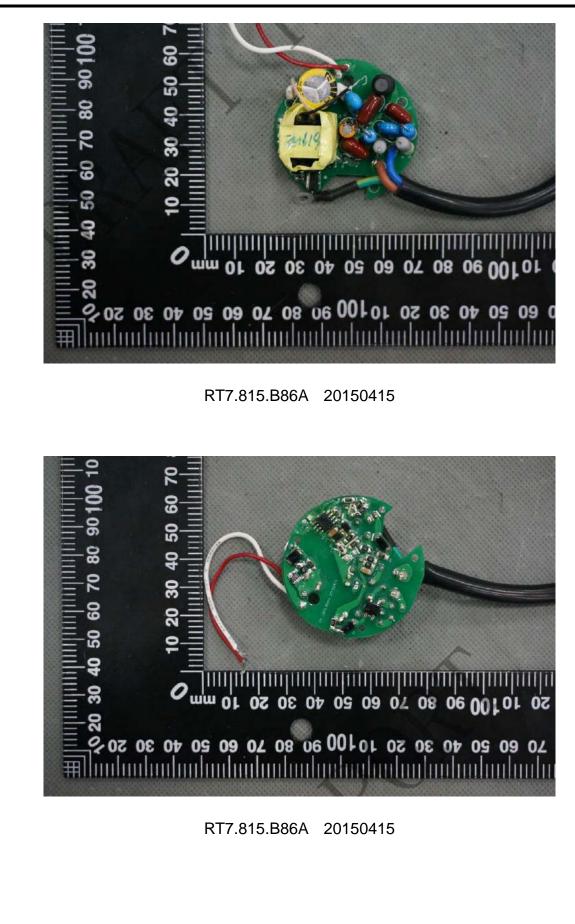




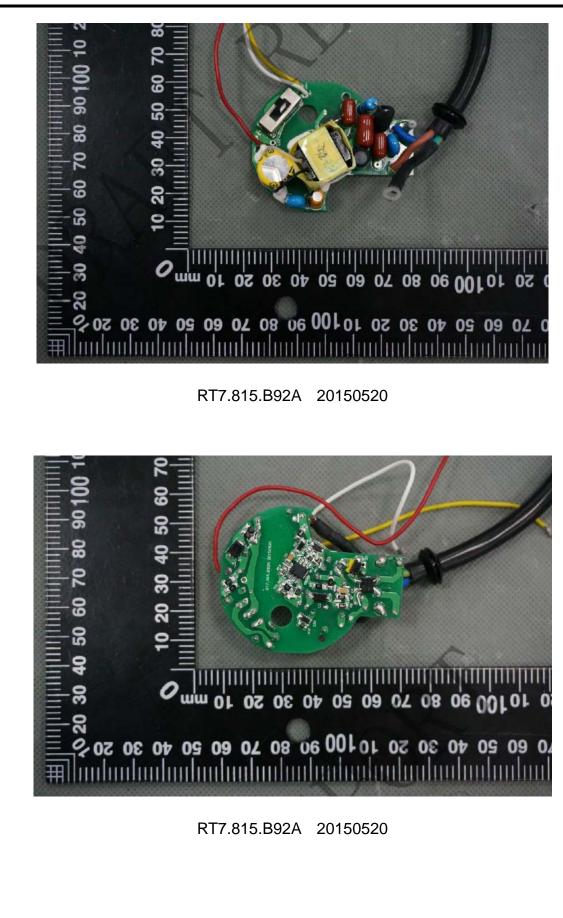




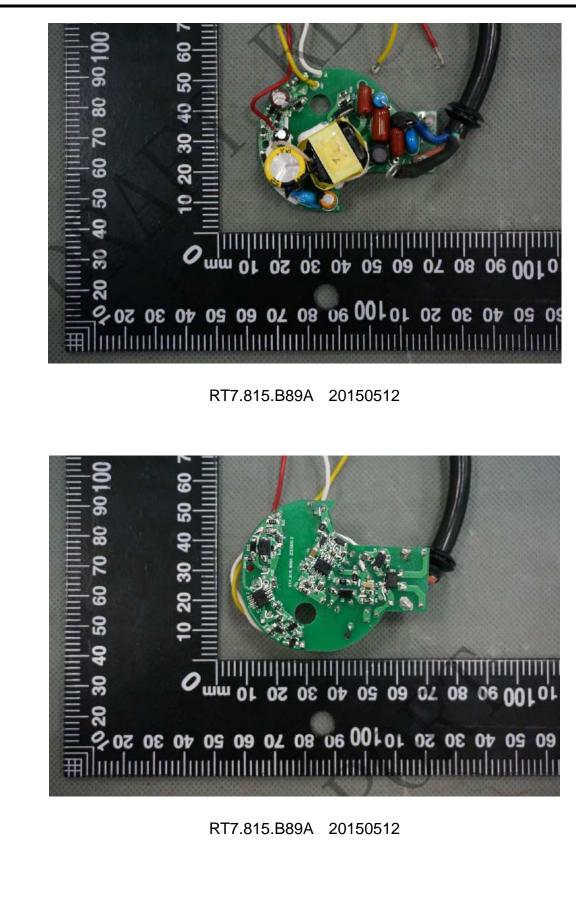
















Appendix II: Photographs of the Test Configuration

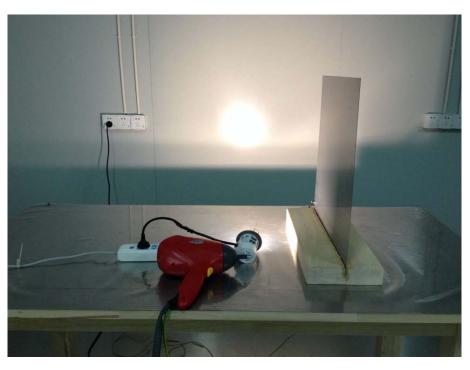
Mains Terminal Disturbance Voltage Measurement

Radiated Electromagnetic Disturbance, Magnetic Component





Electrostatic Discharge Immunity Test



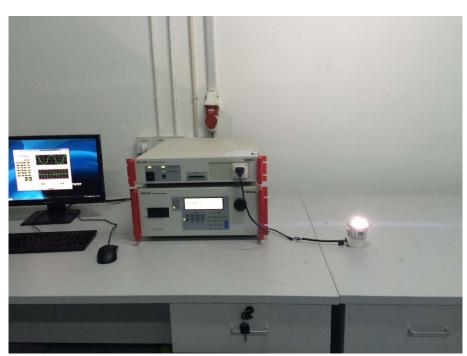
Surge immunity, Electrical fast transient burst immunity,

Voltage dips and short interruptions immunity Test

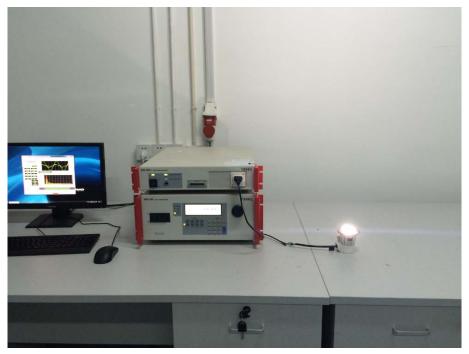




Flicker

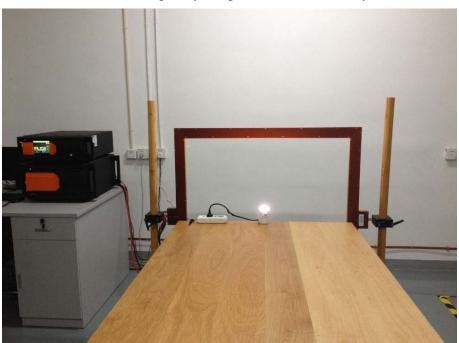


Harmonic





Power Frequency Magnetic Field Immunity



End of Report